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| APPLICATION NO.  | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. |
|--|-------------|----------------------|---------------------|------------------|
| 10/660,561   | 09/12/2003  | Jeong-Wook Lee       | 030681-572          | 5312             |
| 21839  | 7590        | 07/11/2005           | EXAMINER            |                  |
| BUCHANAN INGERSOLL PC<br>(INCLUDING BURNS, DOANE, SWECKER & MATHIS)<br>POST OFFICE BOX 1404<br>ALEXANDRIA, VA 22313-1404 |             |                      | MULPURI, SAVITRI    |                  |
|  |             |                      | ART UNIT            | PAPER NUMBER     |
|  |             |                      | 2812                |                  |

DATE MAILED: 07/11/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

H.A

|                              |                                      |                                   |  |
|------------------------------|--------------------------------------|-----------------------------------|--|
| <b>Office Action Summary</b> | <b>Application No.</b><br>10/660,561 | <b>Applicant(s)</b><br>LEE ET AL. |  |
|                              | <b>Examiner</b><br>Savitri Mulpuri   | <b>Art Unit</b><br>2812           |  |

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

**Period for Reply**

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

**Status**

- 1) ☒ Responsive to communication(s) filed on 5/5/2005.
- 2a) ☒ This action is **FINAL**.                      2b) ☐ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

**Disposition of Claims**

- 4) ☒ Claim(s) 1-17 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) ☐ Claim(s) \_\_\_\_\_ is/are allowed.
- 6) ☒ Claim(s) 1-17 is/are rejected.
- 7) ☐ Claim(s) \_\_\_\_\_ is/are objected to.
- 8) ☐ Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

**Application Papers**

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on \_\_\_\_\_ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.  
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

**Priority under 35 U.S.C. § 119**

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).  
a) ☐ All    b) ☐ Some \* c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- \* See the attached detailed Office action for a list of the certified copies not received.

**Attachment(s)**

- |  |   |
|--|---|
| 1) <input type="checkbox"/> Notice of References Cited (PTO-892)   | 4) <input type="checkbox"/> Interview Summary (PTO-413)<br>Paper No(s)/Mail Date. _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948)                                   | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152)             |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)<br>Paper No(s)/Mail Date _____ | 6) <input type="checkbox"/> Other: _____  |

### DETAILED ACTION

This action is in response to the applicant/s communication filed on 5/5/2005.

#### ***Claim Rejections - 35 USC § 103***

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 1-17 are rejected under 35 U.S.C. 103(a) as being unpatentable over ).

Zhang et al. In combination with Tsakalakos et al (US 20040077156)

Zhang et al teaches a method of manufacturing a device by the following process steps:

Sequentially stacking a first semiconductor layer "82", a mask layer"96" and a metal layer "84"on a substrate (see fig. 5B);

anodizing the metal layer to transform metal layer into a metal oxide layer "86"including a plurality of nanoholes"88"(see fig.5C)

etching the mask layer using the metal oxide layer as an etch mask until the nanoholes "98" are extended to the surface of the first semiconductor layer (see fig.5D);

removing the metal oxide layer by etching; and depositing a second conductive not eh mask layer and the first semiconductor layer "90a,90b,92 (see fig. 5D- 5F and para. 0041).

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In re. to cl. 2, the diameter of the nanoholes is 10 to 100 nm (para. 0038, lines 1-8).

In re. to cl. 3, Zhang et al the area of the holes are inherently less than 50 percent of the whole area by showing metal oxide "86" wider than nanoholes "88" (see the fig. 5 C)

In re cl. 4 mask thicknesses must inherently same as claimed thickness., because both Zhang et al and instant invention has same goal of forming nanoholes with same diameter.

In re. to cl.5, Zhang et al uses a substrate made of GaAs and semiconductor layer made of AlGaAs and both GaAs and AlGaAs have different lattice constants.

In re. to cl. 6 the substrate is GaAs(see fig.5A)

In re. to cl.9 , cl. 11 the mask is dielectric layer of silicon oxide "96"

In re. to cl. 12-14 Zhang further use refractory metal such titanium along with aluminum as metal layer, wherein titanium along with aluminum for good adhesion(see page 4, para. 0029).

In re. to cl. 15 etching is ion etching, which is dry etching (see para 0028, last 6 lines).

In re cl. 16 electrical charge storing material material of semiconductor "90a ,90b) is deposited in nanoholes.

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Zhang et al do not teach growing GaN based compound semiconductor layer in the nanoholes.

Tsakalagos et al teaches growing GaN based compound semiconductor layer in the nanoholes. Tsakalagos et al also teaches forming nanoholes in the mask of dielectric material "302" (see fig. 4) or mask formed from first semiconductor layer of GaN based material "102" called as defective buffer layer (see fig. 5). Growing a second GaN layer in the mask formed from first semiconductor of GaN layer "102", wherein the second GaN layer is grown until the GaN defective buffer mask is fully covered.

It would have been obvious to one of ordinary skill in the art to grow GaN based semiconductor materials in the invention of Zhang et al because compared to GaAs, GaN has large band gap material and so can withstand high temperature and withstand high voltages during performance, it has higher peak carrier velocity, versatile for making several types of devices and good for high frequency operations. It also would have been obvious to use semiconductor material as a mask in the invention of Zhang et al because Tsakalagos et al teaches using either dielectric material or GaN material as a recognized equivalent materials to use as nanohole masks to grow nanohole GaN materials within and above the nanohole mask.

### ***Response to Arguments***

Applicant's arguments filed on 5/5/2005 have been fully considered but they are not persuasive. Applicant argues that Tsakalagos et al teaches nanolithography

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technique, which is contrary to non-photo-lithographic technique of Zhang et al, as mentioned above, Zhang et al substantially teaches the claimed process except growing GaN in the GaN mask with nanoscale features. However, Tsakalakos et al is relied on only to the teaching of growing compound semiconductor GaN in the order of nanoscale range with in the mask of GaN, with nanoscale features.

**THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Savitri Mulpuri whose telephone number is 571-272-1677. The examiner can normally be reached on Mon-Fri from 8 a.m to 4.30 p.m.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael Lebentritt, can be reached on 571-272-1783. The fax phone

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number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).



Savitri Mulpuri  
Primary Examiner  
Art Unit 2812